

Notice of References Cited	Application/Control No. 09/989,530	Applicant(s)/Patent Under Reexamination NAKAI ET AL.	
	Examiner Deborah Yee	Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,950,191	4-1976	Ito et al.	148/330
	B	US-			
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	D	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	English abstract of Japanese publication 2000144330A, Derwent 416079, May 26, 2000
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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